



VMDSEMI

VSXX060R22BNA

Datasheet

General Description

The VSXX060R22BNA is a high voltage power MOSFET, fabricated using advanced super junction technology. The resulting device has extremely low on resistance, low gate charge and fast switching time. The VSXX060R22BNA break down voltage is 600V and it has a high rugged avalanche characteristics. The VSXX060R22BNA is available in TO-251, TO-252 and TO-220F packages.

Symbol

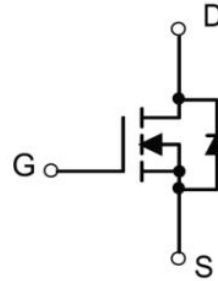


Figure 1 Symbol of VSXX060R22BNA

Features

- Low $R_{DS(ON)_{max}} = 2.2\Omega @ V_{GS} = 10V$
- Ultra Low Gate Charge, $Q_g = 1.5nC$ typ.
- Ultra Fast switching capability
- Robust design with better EAS performance

Package Type

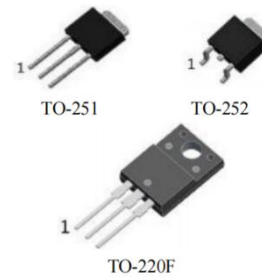
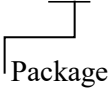


Figure 2 Package Type of VSXX060R22BNA

Application

- LED Lighting Power
- General Used Charger / Adapter

Ordering Information

		VSXX060R22BNA
TO-251:	TJ	 Package
TO-252:	TL	
TO-220F:	TD	

Product Name	Package
VSTJ060R22BNA	TO-251
VSTL060R22BNA	TO-252
VSTD060R22BNA	TO-220F

Absolute Maximum Ratings^{Note1}

Parameter		Symbol	Rating	Unit
Drain-Source Voltage		V_{DS}	600	V
Gate-Source Voltage		V_{GS}	±30	V
Continuous Drain Current	$T_C=25^{\circ}C$	I_D	1.9	A
	$T_C=125^{\circ}C$		0.8	
Pulsed Drain Current ^{Note 2}		I_{DM}	5.5	A
Avalanche Energy, Single Pulse ^{Note 3}		E_{AS}	11	mJ
Avalanche Energy, Repetitive ^{Note 2}		E_{AR}	0.05	mJ
Avalanche Current, Repetitive ^{Note 2}		I_{AR}	0.57	A
Continuous Diode Forward Current		I_S	1.9	A
Diode Pulse Current		$I_{S,PULSE}$	5.5	A
Operating Junction Temperature		T_J	150	°C

Note:

- Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
- Repetitive Rating: Pulse width limited by maximum junction temperature
- $I_{AS} = 0.57A$, $V_{DD} = 60V$, $R_G = 25\Omega$, Starting $T_J = 25^{\circ}C$

Electrical Characteristics ($T_J = 25\text{ }^\circ\text{C}$, unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	$B_{V_{DS}}$	$V_{GS}=0V, I_D=250\mu A$	600			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$			1	μA
Gate-Body Leakage Current	Forward	$V_{GS}=30V, V_{DS}=0V$			100	nA
	Reverse	$V_{GS}=-30V, V_{DS}=0V$			- 100	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.6	3.5	4.4	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=0.5A$		1.82	2.2	Ω
Gate Resistance	R_G	$f=1MHz, \text{Open Drain}$		6.7		Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=25V$		50		pF
Output Capacitance	C_{OSS}	$V_{GS}=0V$		72		
Reverse Transfer Capacitance	C_{RSS}	$f=1MHz$		1.6		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=400V$		20		ns
Rise Time	t_r	$I_D=1.0A$		7		
Turn-off Delay Time	$t_{d(off)}$	$R_G=10\Omega$		40		
Fall Time	t_f	$V_{GS}=10V$		7		
Gate Charge Characteristics						
Gate to Source Charge	Q_{gs}	$V_{DD}=480V$ $I_D=1.0A$		0.48		nC
Gate to Drain Charge	Q_{gd}			0.55		
Gate Charge Total	Q_g			1.5		
Gate Plateau Voltage	$V_{plateau}$	$V_{GS}=0 \text{ to } 10V$		5.7		V
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=1A$		0.84	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=100V,$		110		ns
Reverse Recovery Charge	Q_{rr}	$I_F=1.0A$		0.44		μC
Peak Reverse Recovery Current	I_{rrm}	$dI_F/dt=100A/\mu s$		7.0		A

Typical Performance Characteristics

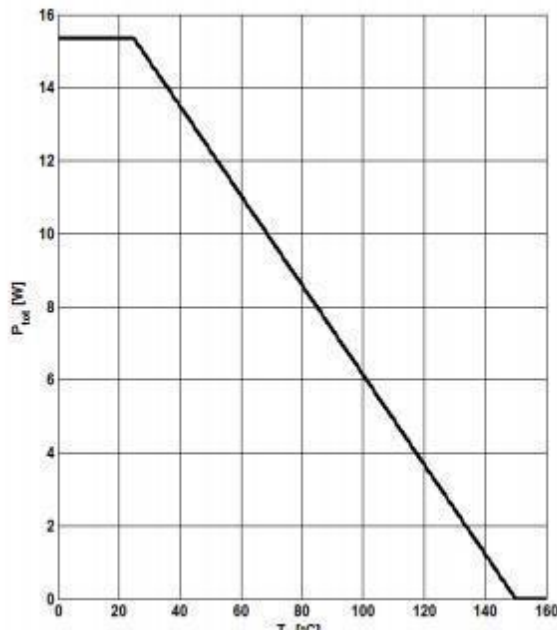
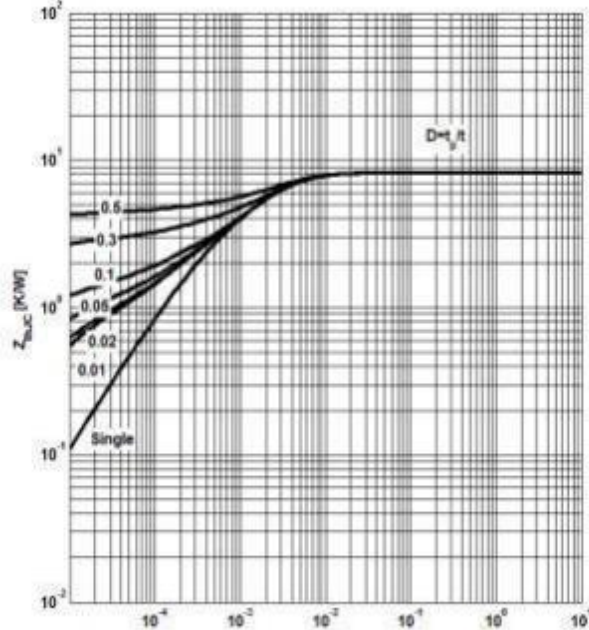
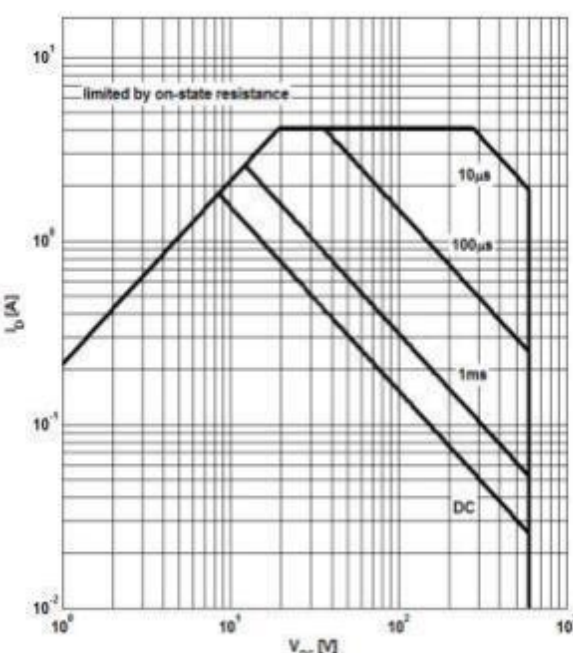
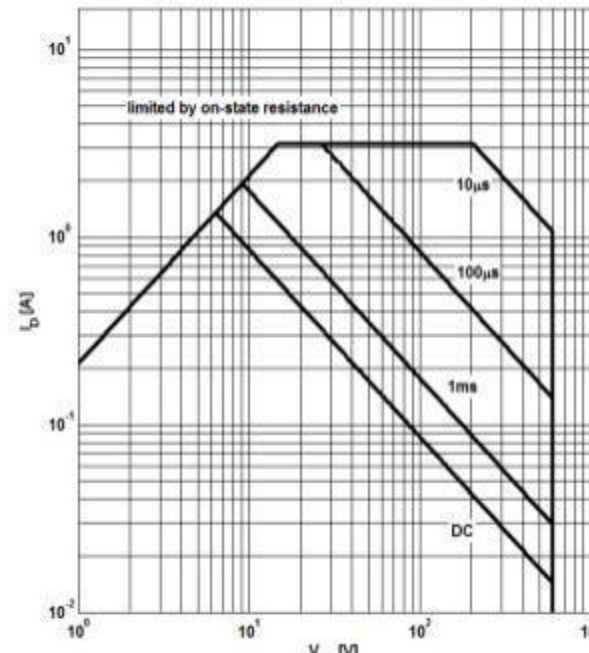
<p style="text-align: center;">Figure 3: Power Dissipation</p> 	<p style="text-align: center;">Figure 4: Max. Transient Thermal Impedance</p> 
$P_{tot} = f(T_c)$	$Z_{thJC} = f(t_p)$; parameter: $D = t_p/T$
<p style="text-align: center;">Figure 5: Safe Operating Area</p>	<p style="text-align: center;">Figure 6: Safe Operating Area</p>
	
$I_D = f(V_{DS})$; $T_c = 25^\circ\text{C}$; $V_{GS} > 7\text{V}$; parameter t_p	$I_D = f(V_{DS})$; $T_c = 80^\circ\text{C}$; $V_{GS} > 7\text{V}$; parameter t_p

Figure 7: Typ. Output Characteristics

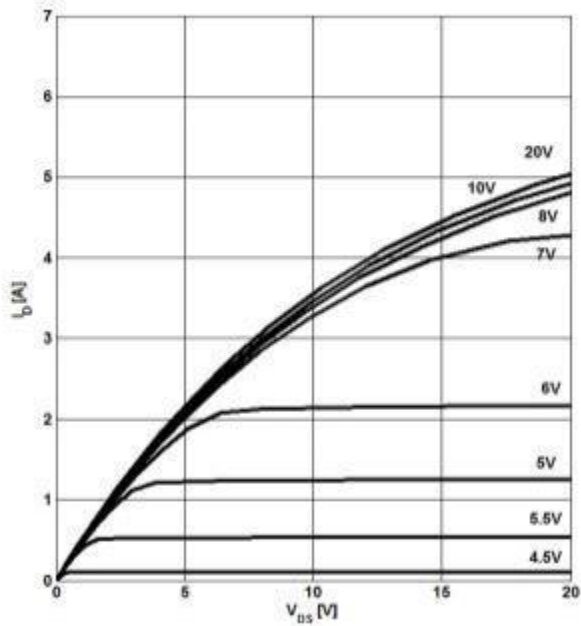

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$

Figure 8: Typ. Output Characteristics

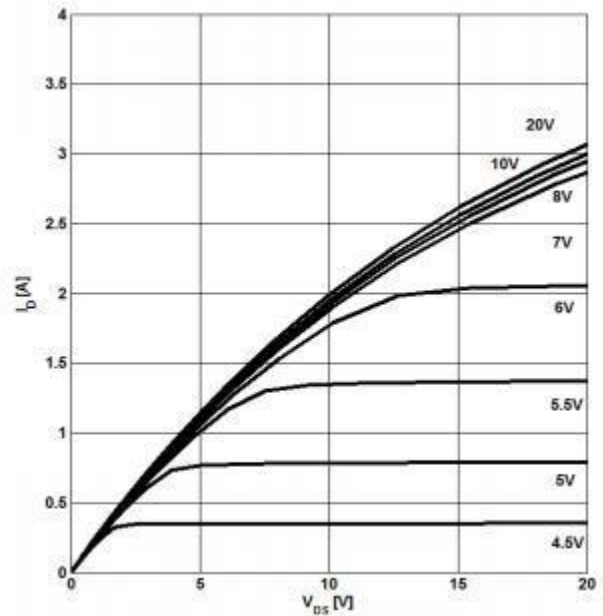

 $I_D = f(V_{DS}); T_j = 125^\circ\text{C}; \text{parameter: } V_{GS}$

Figure 9: Typ. Drain-Source On-State Resistance

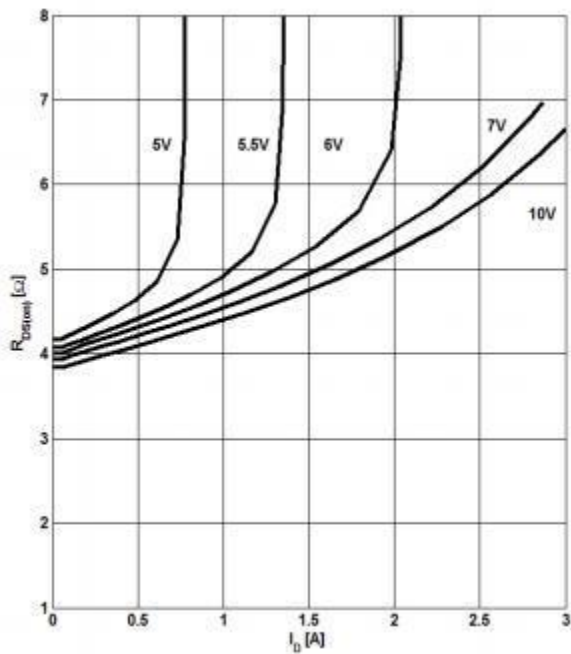

 $R_{DS(ON)} = f(I_D); T_j = 125^\circ\text{C}; \text{parameter: } V_{GS}$

Figure 10: Typ. Drain-Source On-State Resistance

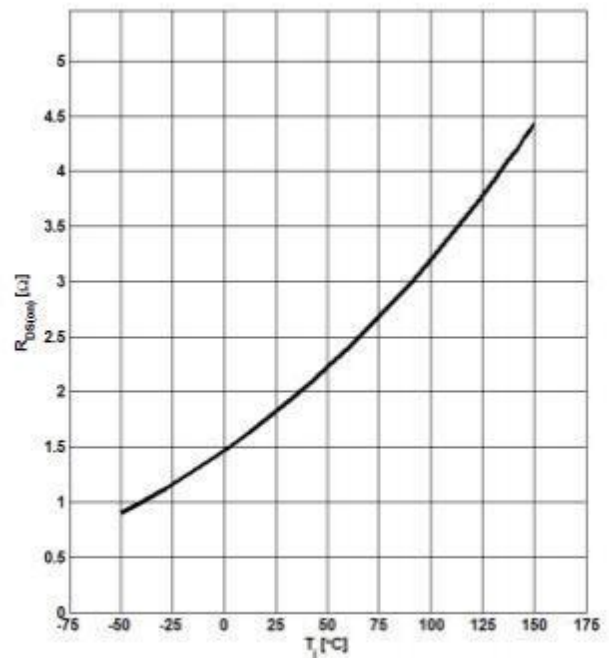
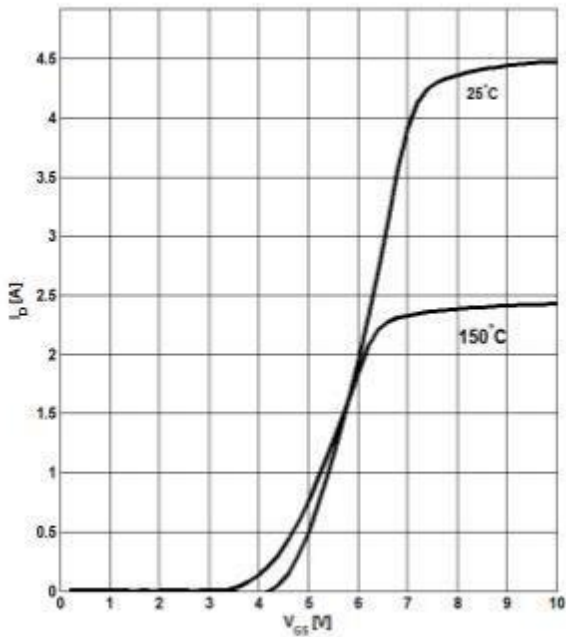
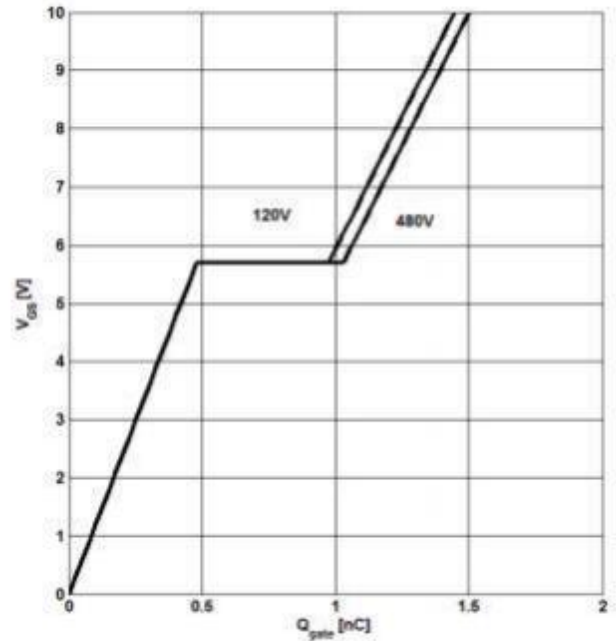

 $R_{DS(ON)} = f(T_j); I_D = 0.5\text{A}; V_{GS} = 10\text{V}$

Figure 11: Typ. Transfer Characteristics



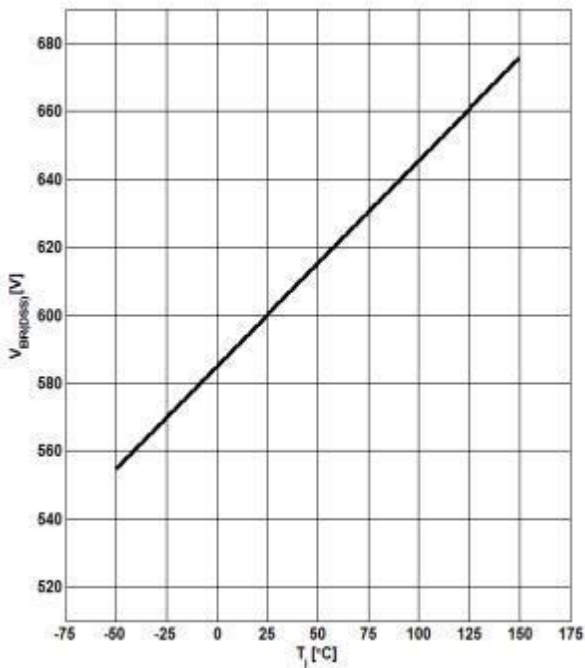
$$I_D = f(V_{GS}); V_{DS} = 20V$$

Figure 12: Typ. Gate Charge



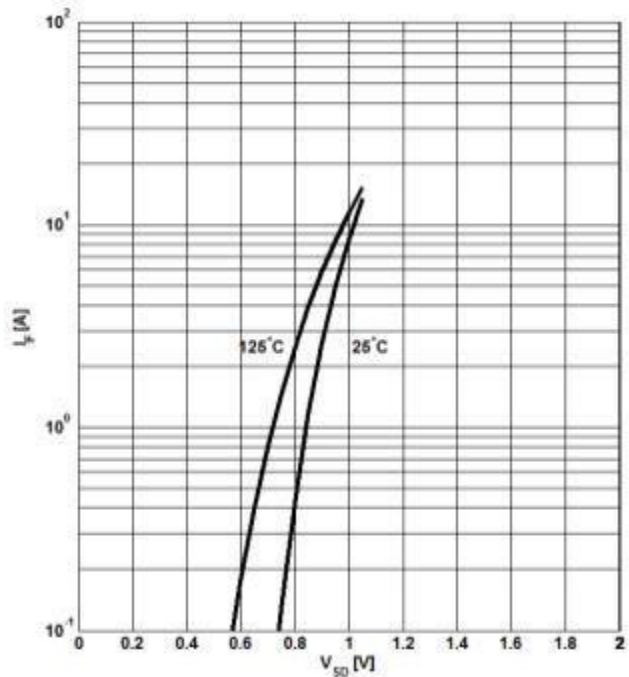
$$V_{GS} = f(Q_{gate}), I_D = 1.0A \text{ pulsed}$$

Figure 13: Drain-Source Breakdown Voltage

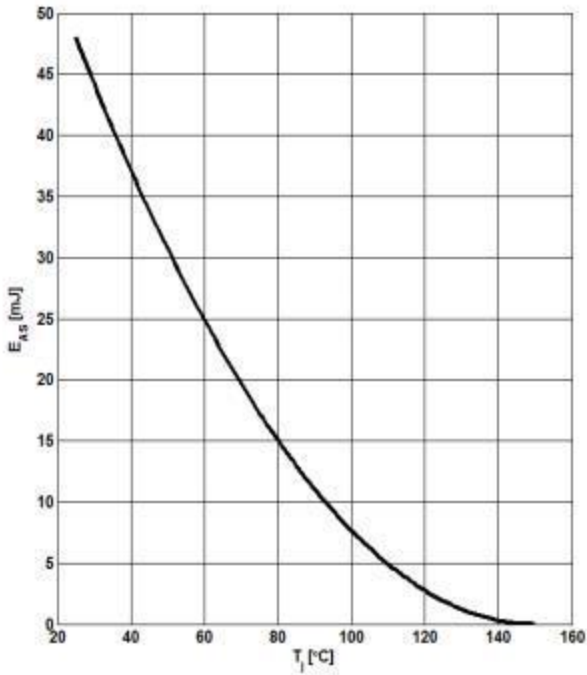


$$V_{BR(DSS)} = f(T_j); I_D = 1mA$$

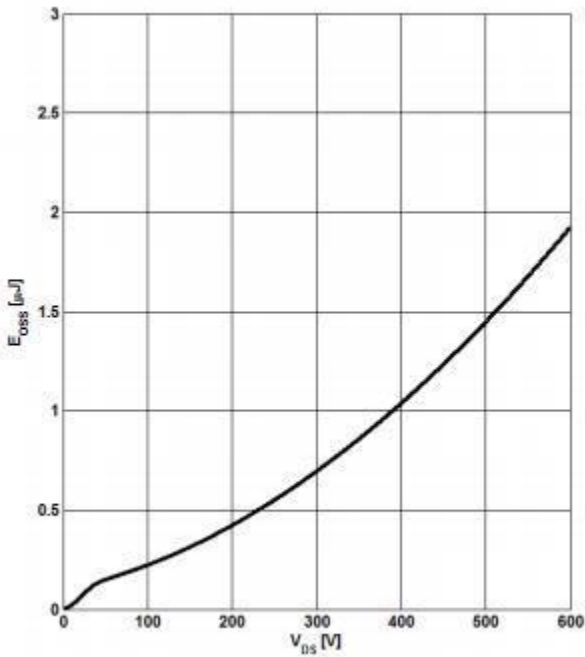
Figure 14: Forward Characteristics of Reverse Diode



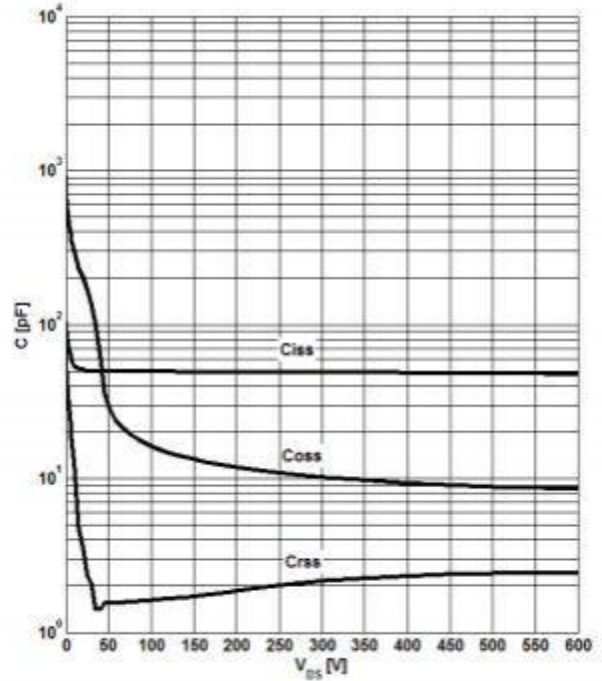
$$I_F = f(V_{SD}); \text{parameter: } T_j$$

Figure 15: Avalanche Energy


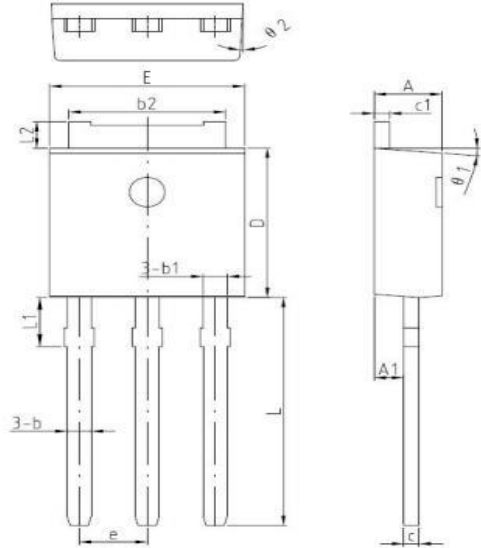
$$E_{AS}=f(T_j); I_D=0.9A; V_{DD}=60V$$

Figure 17: C_{OSS} Stored Energy


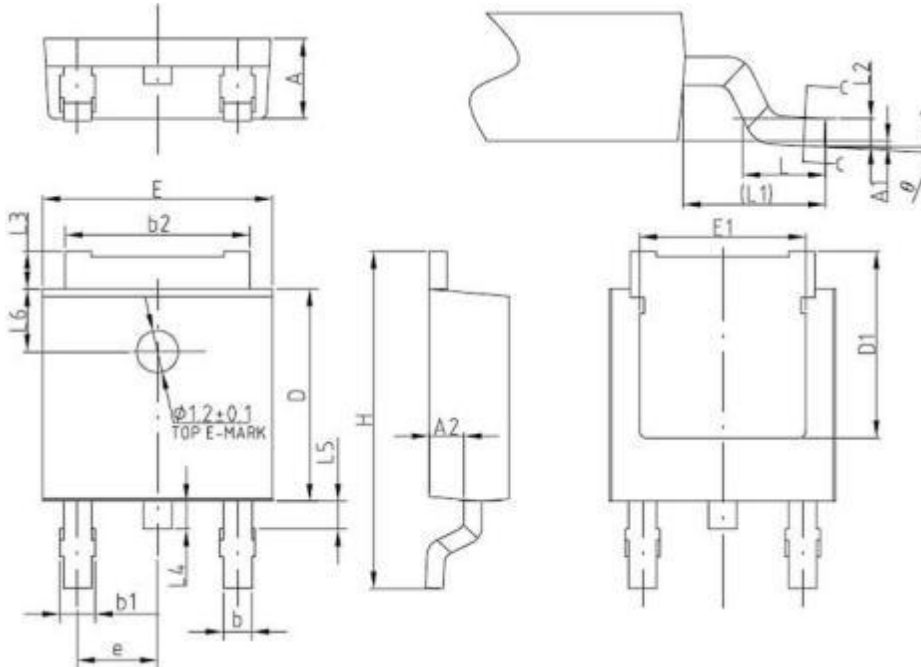
$$E_{OSS}=f(V_{DS})$$

Figure 16: Typ. Capacitances


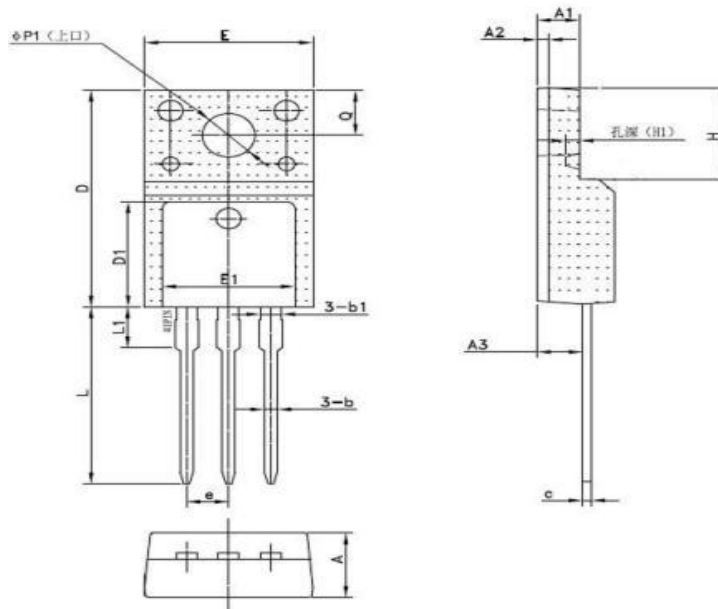
$$C=f(V_{DS}); V_{GS}=0; f=1MHz$$

Mechanical Dimensions:
TO-251 Package Information

Unit: mm

Symbol	Dimensions(mm)		
	Min	Typ	Max
A	2.20	2.30	2.40
A1	0.90	1.01	1.17
b	0.50	-	0.91
b1	-	0.81	-
b2	5.13	5.33	5.46
c	0.46	0.50	0.60
c1	0.46	0.50	0.60
D	5.95	6.10	6.25
E	6.45	6.60	6.75
e	2.286(BSC)		
L	9.00	9.30	9.60
L1	-	2.00	-
L2	0.90	-	1.25
θ1	-	5°	-
θ2	-	3°	-

Mechanical Dimensions:
TO-252 Package Information

Unit: mm

Symbol	Dimensions(mm)		
	Min	Typ	Max
A	2.20	2.30	2.40
A1	0	-	0.10
A2	0.90	1.00	1.17
b	0.70	0.76	0.90
b1	0.77	-	1.10
b2	5.13	5.33	5.46
c	0.45	-	0.60
D	5.95	6.10	6.25
D1	-	5.30	-
E	6.45	6.60	6.75
E1	-	4.80	-
e	2.286(BSC)		
H	9.70	10.10	10.40
L	1.25	1.50	1.75
L1	-	2.90	-
L2	-	0.51	-
L3	0.90	-	1.25
L4	-	0.80	-
L5	-	1.00	-
L6	-	1.80	-
θ	0°	-	8°

Mechanical Dimensions:
TO-220F Package Information

Unit: mm

Symbol	Dimensions(mm)		
	Min	Typ	Max
A	4.30	4.70	4.90
A1	2.34	2.54	2.90
A2	-	0.70	-
A3	2.56	2.76	2.96
b	0.55	-	0.95
b1	-	1.28	-
c	0.42	0.50	0.70
D	14.70	-	16.07
D1	-	7.70	-
E	9.96	10.16	10.36
E1	-	8.00	-
e	2.54(BSC)		
H	-	6.70	-
(H1)	-	(0.81)	-
L	12.48	12.98	13.50
L1	-	2.93	-
ΦP1	-	3.18	-
Q	2.90	3.30	3.50

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